

E070069 -A- D

Drawing No

SPECIFICATION

Sheet 1 2 of

Rev. Group

Septum Window Polish, Enhanced LIGO

| | | | APPROVALS | | |
|----------------|-----------|---------|-----------|-----|---------|
| AUTHOR: | CHECKED: | DATE | DCN NO. | REV | DATE |
| G. Billingsley | M. Zucker | 4-27-07 | E070094 | Α | 4-27-07 |
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Applicable Documents

LIGO-D070082-A

ELI Septum Window

Requirements

Physical Configuration

According to LIGO-D070082-A ELI Septum Window

Fabricate from Corning grade 0AA fused silica or equivalent

Part and Serial Number

The Serial number shall be per D070082 and of the format: ESW YY Where is incremental for each optic starting at 01 YY

Registration Mark

Registration mark shall be etched, ground or sandblasted

Side and Bevel Polish

All sides and Bevels shall be polished from a five micrometer grit finish. These surfaces shall appear transparent with no gray, scuffs or scratches visible to the naked eye when viewed in normal room light against a black background.

Scratches and Point defects within the clear aperture defined by D070082

Scratches and point defects are to be minimized as scattered light is highly detrimental to the project. Requirement: 20/10 Goal: 10/5





E070069 -A- D

Drawing No Rev. Group Sheet 2 of 2

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Surfaces 1 and 2, measured over the central 140 mm diameter

Surface Figure: deviation from flat < 10 nm rms

High Spatial Frequency Band: Micro-roughness is measured with a commercial microscopic interferometer or surface profiler.

 σ_{rms} < 0.1 nanometers

Measured at the following locations:

1. The center of the mirror substrate.

2. Four positions equally spaced along the circumference of a centered, 60 mm diameter circle.

| Specification | Test Method | Frequency of Inspection | Data Delivered |
|--|--------------------------------|----------------------------|----------------|
| Physical Dimensions | Visual Inspection | 100% | Certification |
| Side and Bevel Polish | Visual Inspection | 100% | Certification |
| Scratches and Point defects | Visual Inspection | 100% | Certification |
| Surface Figure | Interferometry | 100% | Surface Map |
| Surface Errors – High Spatial Frequency | High resolution Surface Map | 100% | Certification |